SGS-THOMSON MICROELECTRONICS

M54/74HC245/640/643
M54/74HC245/640/643

OCTAL BUS TRANSCEIVER (3-STATE): HC245 NON INVERTING HC640 INVERTING, HC643 INVERTING/NON INVERTING

- HIGH SPEED
  $t_{PD} = 10$ ns (TYP.) at $V_{CC} = 5$V
- LOW POWER DISSIPATION
  $I_{CC} = 4$ μA (MAX.) at $T_A = 25$ ^oC
- HIGH NOISE IMMUNITY
  $V_{NIH} = V_{INL} = 28$ % V_{CC} (MIN.)
- OUTPUT DRIVE CAPABILITY
  15 LSTTL LOADS
- SYMMETRICAL OUTPUT IMPEDANCE
  $|I_{OH}| = I_{OL} = 6$ mA (MIN)
- BALANCED PROPAGATION DELAYS
  $t_{PLH} = t_{PHL}$
- WIDE OPERATING VOLTAGE RANGE
  V_{CC} (OPR) = 2 V TO 6 V
- PIN AND FUNCTION COMPATIBLE
  WITH 54/74LS245/640/643

B1R
(Plastic Package)

F1R
(Ceramic Package)

M1R
(Micro Package)

C1R
(Chip Carrier)

ORDER CODES :
M54HCXXXF1R   M74HCXXXM1R
M74HCXXXB1R   M74HCXXXC1R

DESCRIPTION

The M54/74HC245, HC640 and HC643 utilise silicon gate C2MOS technology to achive operating speeds equivalent to LSTTL devices.

Along with the low power dissipation and high noise immunity of standards C^2MOS integrated circuit, it possesses the capability to drive 15 LSTTL loads. These IC's are intended for two-way asynchronous communication between data buses, and the direction of data trasmission is determined by DIR input. The enable input ($\overline{G}$) can be used to disable the device so that the buses are effectively isolated.

All input are equipped with protection circuits against static discharge and transient discharge and transient excess voltage.

IT IS PROHIBITED TO APPLY A SIGNAL TO A BUS TERMINAL WHEN IT IS IN OUTPUT MODE AND WHEN A BUS THERMINAL IS FLOATING (HIGH IMPEDANCE STATE), IT IS REQUESTED TO FIX THE INPUT LEVEL BY MEANS OF EXTERNAL PULL DOWN OR PULL UP RESISTOR.
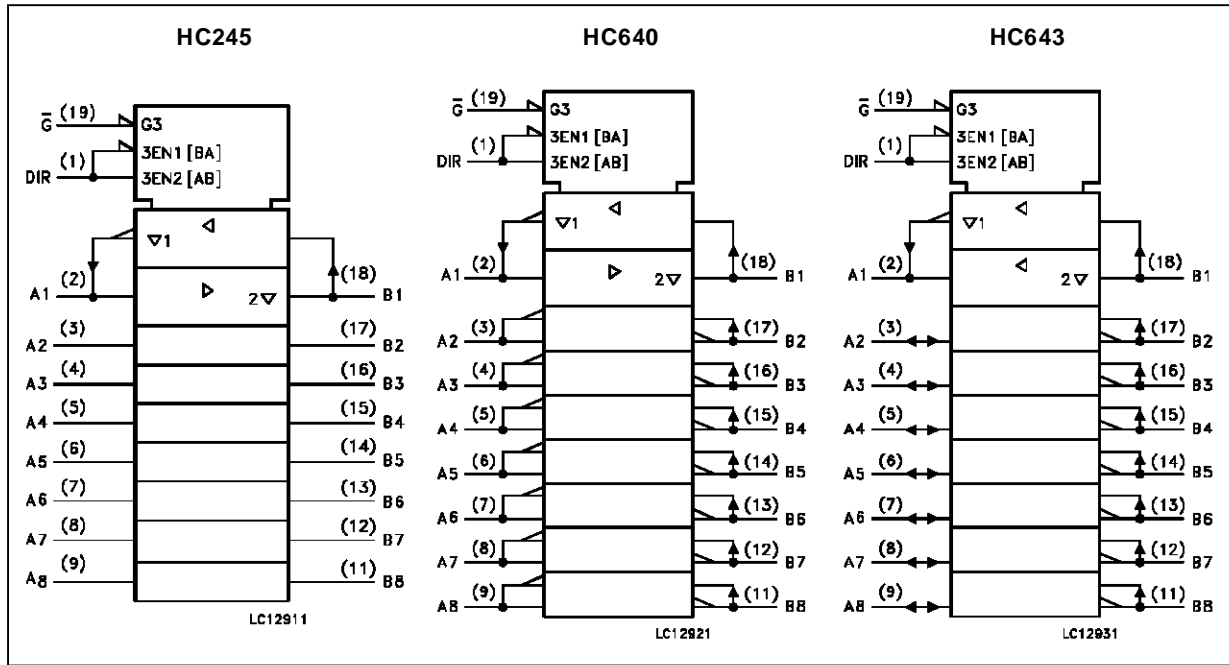
PIN CONNECTION (top view)
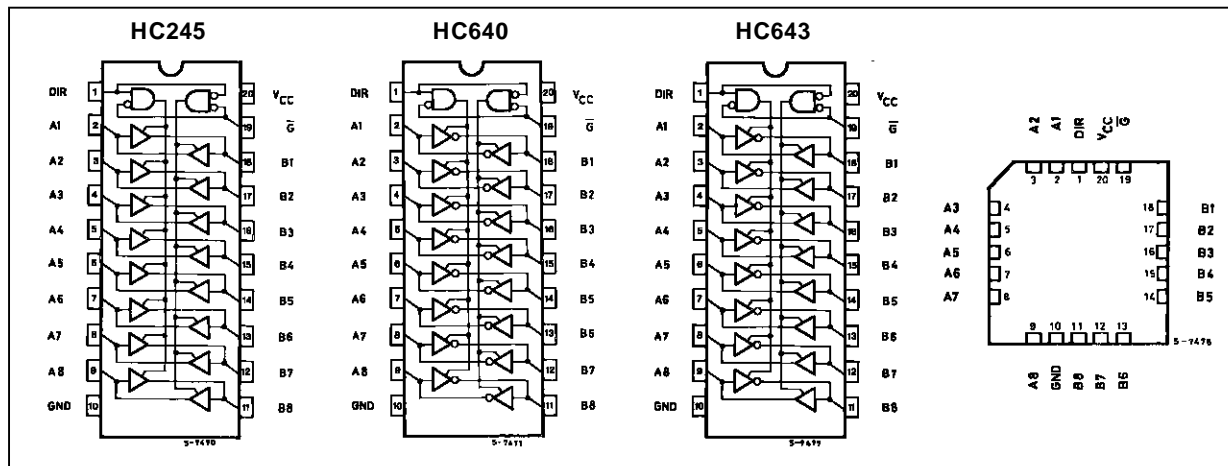
INPUT AND OUTPUT EQUIVALENT CIRCUIT
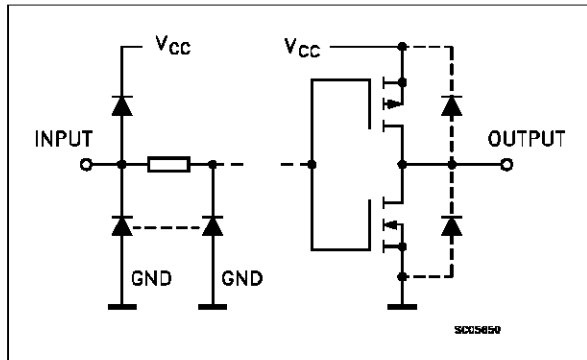
PIN DESCRIPTION

PIN No	SYMBOL	NAME AND FUNCTION
1	DIR	Directional Control
2, 3, 4, 5, 6, 7, 8, 9	A1 to A8	Data Inputs/Outputs
18, 17, 16, 15, 14, 13, 12, 11	B1 to B8	Data Inputs/Outputs
19	$\overline{G}$	Output Enabel Input (Active LOW)
10	GND	Ground (0V)
20	V_{CC}	Positive Supply Voltage

IEC LOGIC SYMBOLS

TRUTH TABLE

INPUT		FUNCTION		OUTPUT		
$\overline{G}$	DIR	A BUS	B BUS	HC245	HC640	HC643
L	L	OUTPUT	INPUT	A = B	A = $\overline{B}$	A = B
L	H	INPUT	OUTPUT	B = A	B = $\overline{A}$	B = $\overline{A}$
H	X	Z	Z	Z	Z	Z

X: "H" or "L"
Z: High impedance

LOGIC DIAGRAM (HC640)
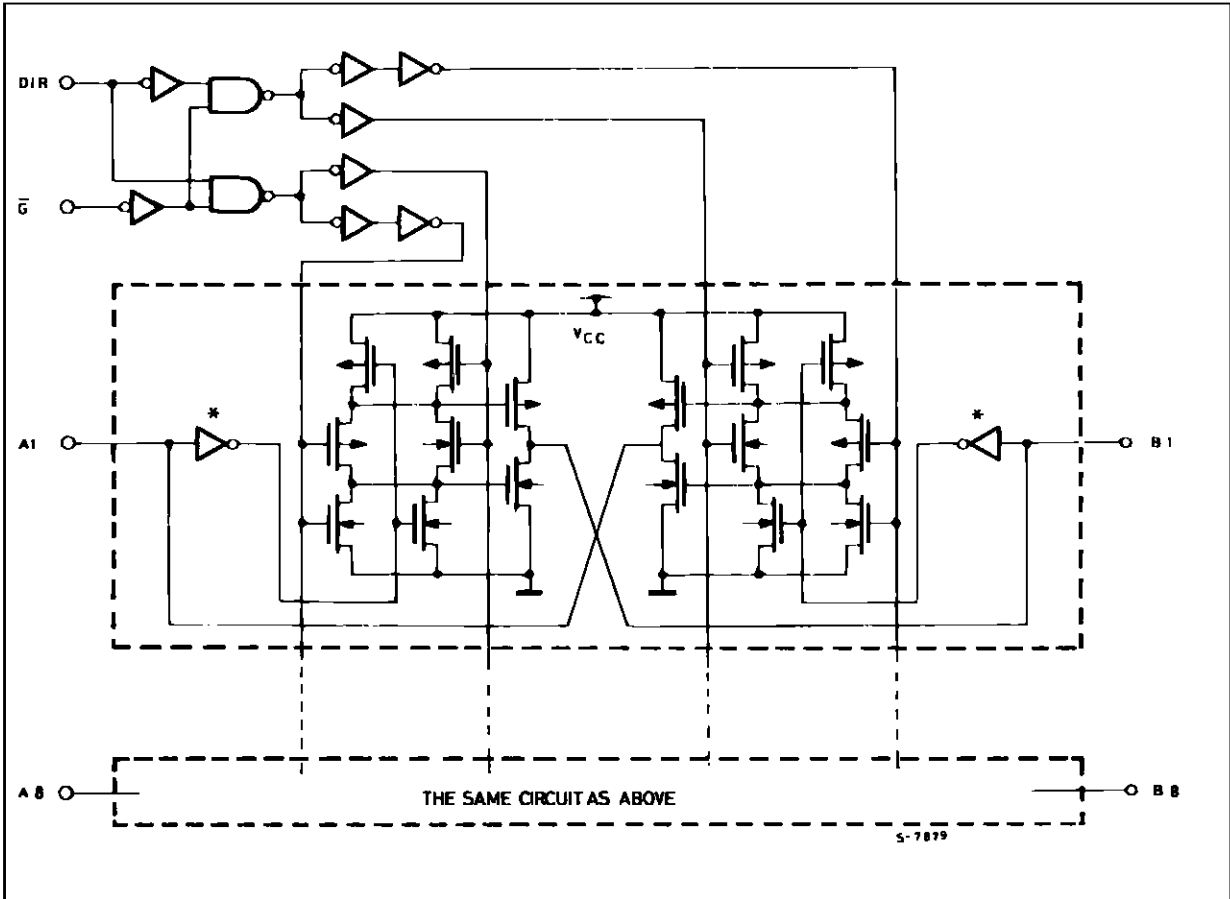
NOTE: IN CASE OF HC245 OR HC643, INPUT INVERTERS MARKED* AT A BUS AND B BUS ARE ELIMINATED RESPECTIVELY

ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	-0.5 to +7	V
V_I	DC Input Voltage	-0.5 to V_{CC} + 0.5	V
V_O	DC Output Voltage	-0.5 to V_{CC} + 0.5	V
I_{IK}	DC Input Diode Current	$\pm$ 20	mA
I_{OK}	DC Output Diode Current	$\pm$ 20	mA
I_O	DC Output Source Sink Current Per Output Pin	$\pm$ 35	mA
I_{CC} or I_{GND}	DC V_{CC} or Ground Current	$\pm$ 70	mA
P_D	Power Dissipation	500 (*)	mW
T_{stg}	Storage Temperature	-65 to +150	^oC
T_L	Lead Temperature (10 sec)	300	^oC

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.
(*) 500 mW: $\cong$ 65 ^oC derate to 300 mW by 10mW/^oC: 65 ^oC to 85 ^oC

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RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Value	Unit
V_{CC}	Supply Voltage		2 to 6	V
V_I	Input Voltage		0 to V_{CC}	V
V_O	Output Voltage		0 to V_{CC}	V
T_{op}	Operating Temperature: **M54HC** Series		-55 to +125	^oC
	M74HC Series		-40 to +85	^oC
t_r, t_f	Input Rise and Fall Time	V_{CC} = 2 V	0 to 1000	ns
		V_{CC} = 4.5 V	0 to 500	
		V_{CC} = 6 V	0 to 400	

DC SPECIFICATIONS

Symbol	Parameter	V_{CC} (V)	Test Conditions		$T_A = 25\ ^oC$ 54HC and 74HC			-40 to 85 ^oC 74HC		-55 to 125 ^oC 54HC		Unit
					Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
V_{IH}	High Level Input Voltage	2.0			1.5			1.5		1.5		V
		4.5			3.15			3.15		3.15		
		6.0			4.2			4.2		4.2		
V_{IL}	Low Level Input Voltage	2.0					0.5		0.5		0.5	V
		4.5					1.35		1.35		1.35	
		6.0					1.8		1.8		1.8	
V_{OH}	High Level Output Voltage	2.0	$V_I = V_{IH}$ or V_{IL}	I_O=-20 µA	1.9	2.0		1.9		1.9		V
		4.5			4.4	4.5		4.4		4.4		
		6.0			5.9	6.0		5.9		5.9		
		4.5		I_O=-6.0 mA	4.18	4.31		4.13		4.10		
		6.0		I_O=-7.8 mA	5.68	5.8		5.63		5.60		
V_{OL}	Low Level Output Voltage	2.0	$V_I = V_{IH}$ or V_{IL}	I_O= 20 µA		0.0	0.1		0.1		0.1	V
		4.5				0.0	0.1		0.1		0.1	
		6.0				0.0	0.1		0.1		0.1	
		4.5		I_O= 6.0 mA		0.17	0.26		0.33		0.40	
		6.0		I_O= 7.8 mA		0.18	0.26		0.33		0.40	
I_I	Input Leakage Current	6.0	$V_I = V_{CC}$ or GND				±0.1		±1		±1	µA
I_{OZ}	3 State Output Off State Current	6.0	$V_I = V_{IH}$ or V_{IL} $V_O = V_{CC}$ or GND				±0.5		±5.0	µA		
I_{CC}	Quiescent Supply Current	6.0	$V_I = V_{CC}$ or GND				4		40		80	µA

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AC ELECTRICAL CHARACTERISTICS $(C_L = 50\ pF$, Input $t_r = t_f = 6\ ns)$

Symbol	Parameter	Test Conditions			Value							Unit
		V_{CC} (V)	C_L (pF)		$T_A = 25\ ^oC$ 54HC and 74HC			-40 to 85 ^oC 74HC		-55 to 125 ^oC 54HC		
					Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
t_{TLH} t_{THL}	Output Transition Time	2.0	50			25	60		75		90	ns
		4.5				7	12		19		18	
		6.0				6	10		13		15	
t_{PLH} t_{PHL}	Propagation Delay Time	2.0	50			33	90		115		135	ns
		4.5				12	18		23		27	
		6.0				10	15		20		23	
		2.0	150			48	120		150		180	ns
		4.5				16	24		30		36	
		6.0				14	20		26		31	
t_{PZL} t_{PZH}	Output Enable Time	2.0	50	$R_L = 1K\Omega$		48	150		190		225	ns
		4.5				16	30		38		45	
		6.0				14	26		32		38	
		2.0	150	$R_L = 1K\Omega$		63	180		225		270	ns
		4.5				21	36		45		54	
		6.0				18	31		38		46	
t_{PLZ} t_{PHZ}	Output Disable Time	2.0	50	$R_L = 1K\Omega$		37	150		190		225	ns
		4.5				17	30		38		45	
		6.0				15	26		32		38	
C_{IN}	Input Capacitance		DIR, $\overline{G}$			5	10		10		10	pF
$C_{I/OUT}$	Output Capacitance		An, Bn			13						pF
C_{PD} (*)	Power Dissipation Capacitance		HC245 HC640/643			39 37						pF

(*) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operting current can be obtained by the following equation. $I_{CC}(opr) = C_{PD} \bullet V_{CC} \bullet f_{IN} + I_{CC}/8$ (per circuit)

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SWITCHING CHARACTERISTICS TEST WAVEFORM
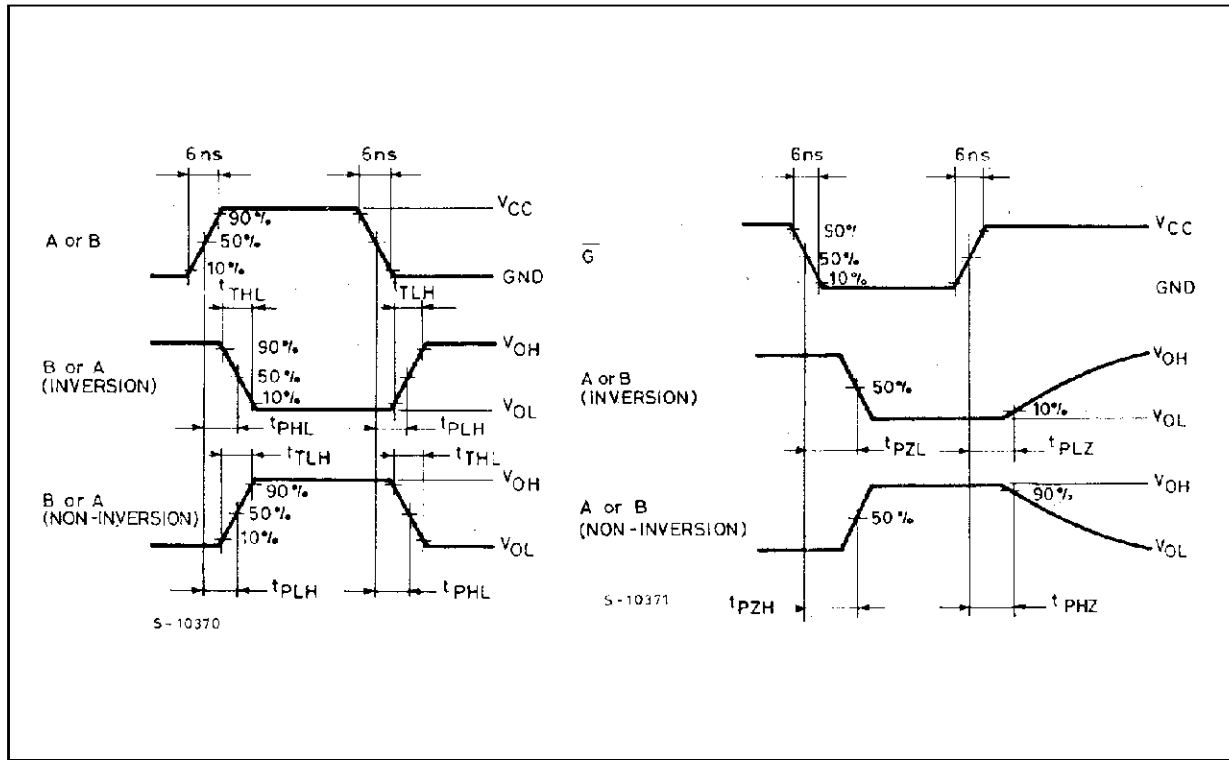
### TEST CIRCUIT I_{CC} (Opr.)
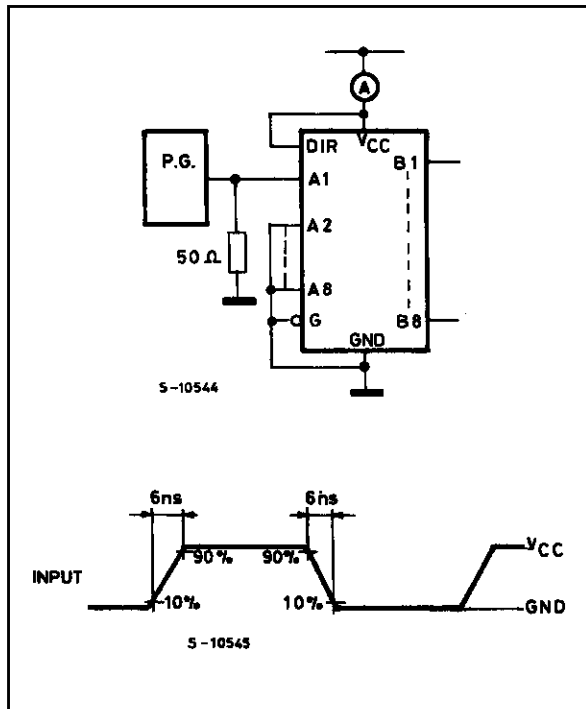
C_{PD} CALCULATION

C$_{PD}$ is to be calculated with the following formula by using the measured value of I$_{CC}$ (Opr.) in the test circuit opposite.

$$C_{PD} = \frac{I_{CC}\,(Opr.)}{f_{IN}\,x\,V_{CC}}$$

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Plastic DIP20 (0.25) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.254			0.010		
B	1.39		1.65	0.055		0.065
b		0.45			0.018	
b1		0.25			0.010	
D			25.4			1.000
E		8.5			0.335	
e		2.54			0.100	
e3		22.86			0.900	
F			7.1			0.280
I			3.93			0.155
L		3.3			0.130	
Z			1.34			0.053

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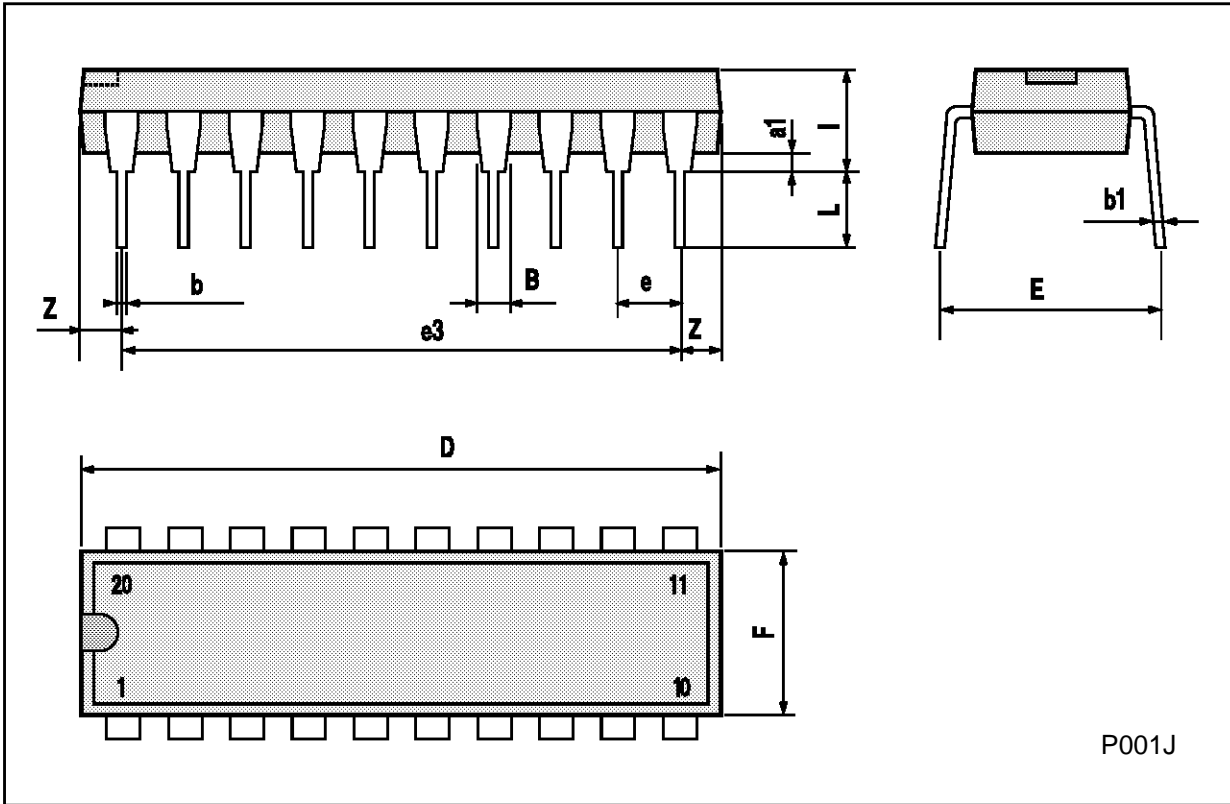
Ceramic DIP20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			25			0.984
B			7.8			0.307
D		3.3			0.130	
E	0.5		1.78	0.020		0.070
e3		22.86			0.900	
F	2.29		2.79	0.090		0.110
G	0.4		0.55	0.016		0.022
I	1.27		1.52	0.050		0.060
L	0.22		0.31	0.009		0.012
M	0.51		1.27	0.020		0.050
N1	4° (min.), 15° (max.)					
P	7.9		8.13	0.311		0.320
Q			5.71			0.225

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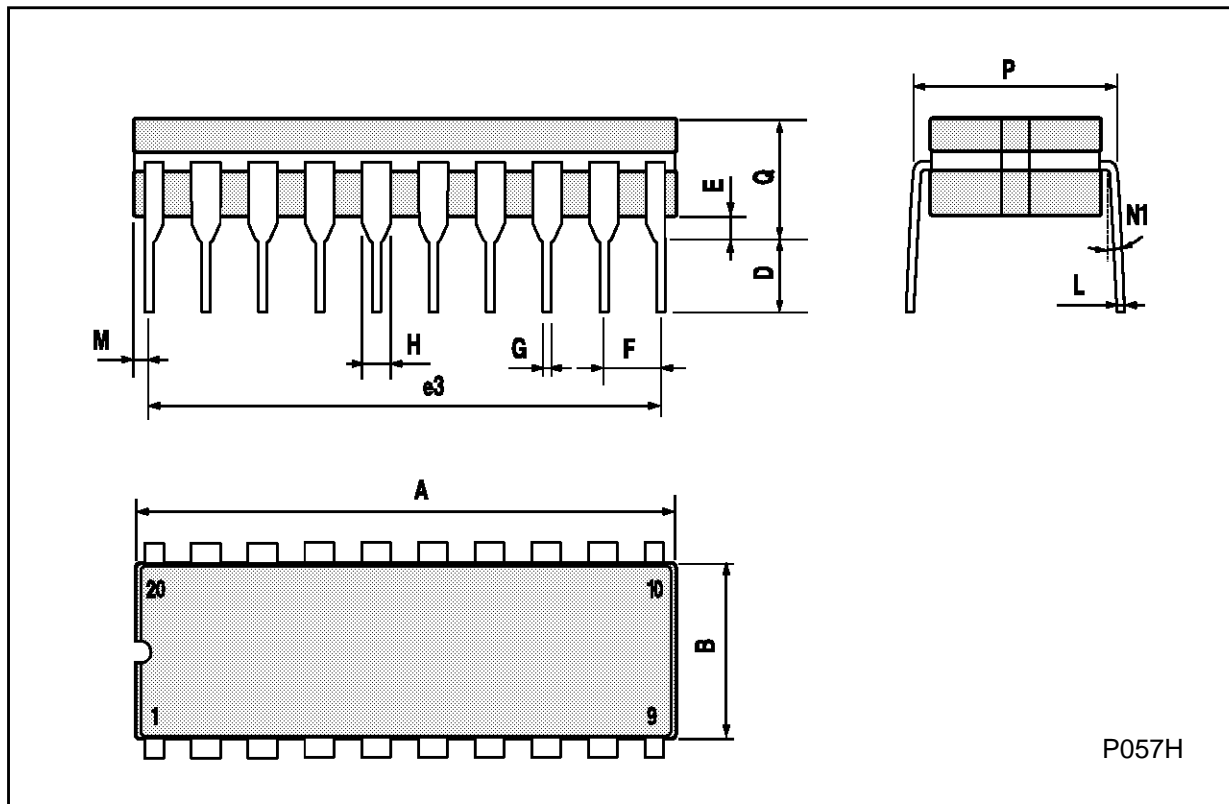
SO20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			2.65			0.104
a1	0.10		0.20	0.004		0.007
a2			2.45			0.096
b	0.35		0.49	0.013		0.019
b1	0.23		0.32	0.009		0.012
C		0.50			0.020	
c1	45° (typ.)					
D	12.60		13.00	0.496		0.512
E	10.00		10.65	0.393		0.419
e		1.27			0.050	
e3		11.43			0.450	
F	7.40		7.60	0.291		0.299
L	0.50		1.27	0.19		0.050
M			0.75			0.029
S	8° (max.)					

P013L

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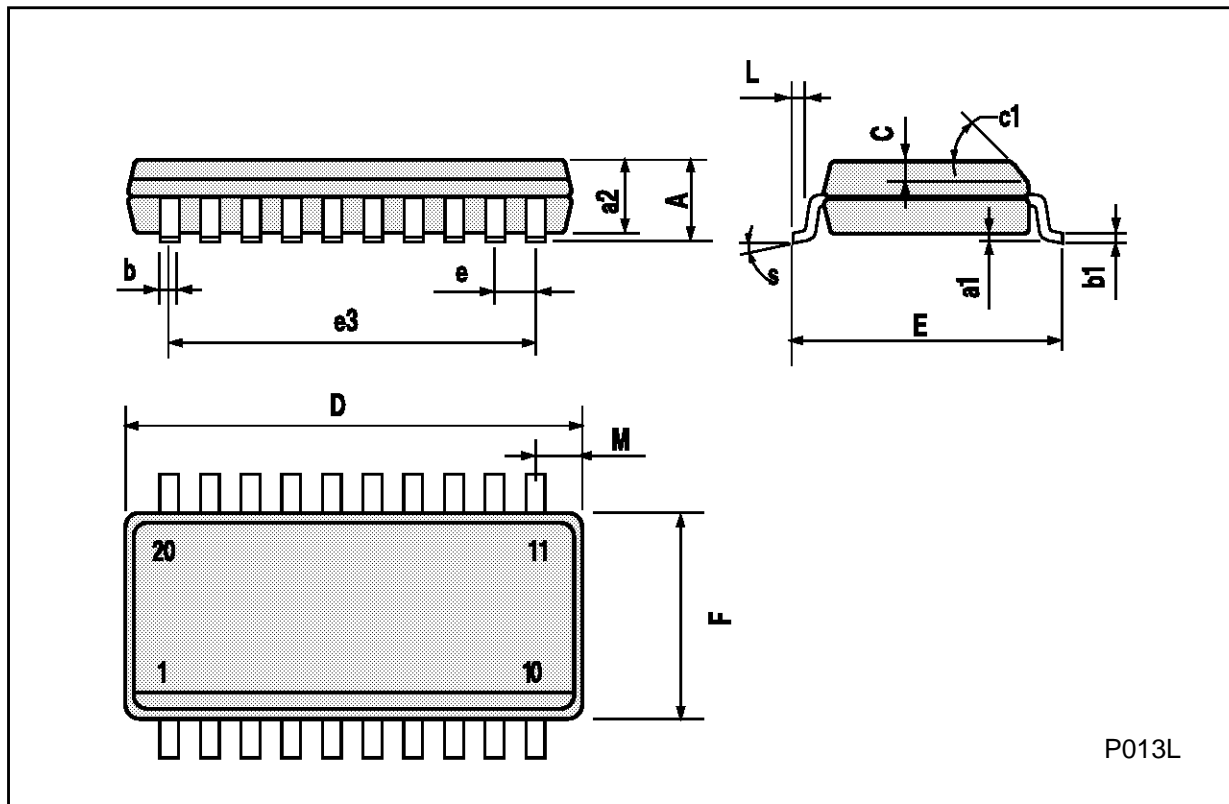
PLCC20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	9.78		10.03	0.385		0.395
B	8.89		9.04	0.350		0.356
D	4.2		4.57	0.165		0.180
d1		2.54			0.100	
d2		0.56			0.022	
E	7.37		8.38	0.290		0.330
e		1.27			0.050	
e3		5.08			0.200	
F		0.38			0.015	
G			0.101			0.004
M		1.27			0.050	
M1		1.14			0.045	

P027A

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